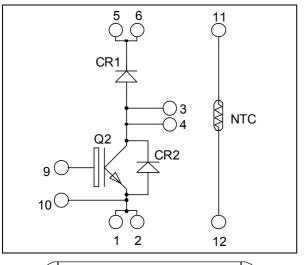
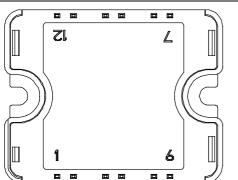


Boost chopper NPT IGBT Power Module

$V_{CES} = 1200V$ $I_{C} = 100 A^{*}$ (a) $T_{C} = 80^{\circ}C$





Pins 1/2; 3/4; 5/6 must be shorted together

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

Features

- Non Punch Through (NPT) Fast IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS** Compliant

Absolute maximum ratings

| Symbol | Parameter | | Max ratings | Unit |
|------------------|---------------------------------------|----------------------------------|--------------|------|
| V _{CES} | Collector - Emitter Breakdown Voltage | | 1200 | V |
| т | Continuous Collector Current | $T_C = 25^{\circ}C$ | 130* | |
| I _C | | $T_C = 80^{\circ}C$ | 100* | Α |
| I _{CM} | Pulsed Collector Current | $T_C = 25^{\circ}C$ | 200 | |
| V _{GE} | Gate – Emitter Voltage | | ±20 | V |
| PD | Maximum Power Dissipation | $T_C = 25^{\circ}C$ | 735 | W |
| RBSOA | Reverse Bias Safe Operating Area | $T_{\rm J} = 150^{\circ}{\rm C}$ | 200A @ 1150V | |

Specification of IGBT device but output current must be limited to 75A to not exceed a delta of temperature greater than 30°C for the connectors.

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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Тур

3.2

3.9

5.5

Max

250

3.7

6.5

600

Unit

μΑ

V

V

nA

All ratings (a) $T_i = 25^{\circ}C$ unless otherwise specified

 $V_{GE} = 20V, V_{CE} = 0V$

Electrical Characteristics Symbol Characteristic **Test Conditions** Min Zero Gate Voltage Collector Current $V_{GE} = 0V, V_{CE} = 1200V$ I_{CES} $V_{GE} = 15V$ $T_i = 25^{\circ}C$ $V_{CE(\text{sat})}$ Collector Emitter Saturation Voltage $I_{\rm C} = 100 {\rm A}$ $T_j = 125^{\circ}C$ $V_{GE} = V_{CE}$, $I_C = 4mA$ V_{GE(th)} 4.5

Dynamic Characteristics

IGES

Gate Threshold Voltage

Gate - Emitter Leakage Current

| Symbol | Characteristic | Test Conditions | Min | Тур | Max | Unit |
|---------------------|------------------------------|---|-----|-----|-----|------|
| Cies | Input Capacitance | $V_{GE} = 0V$ | | 6.5 | | |
| C _{oes} | Output Capacitance | $V_{CE} = 25V$ | | 1 | | nF |
| Cres | Reverse Transfer Capacitance | f = 1 MHz | | 0.5 | | |
| T _{d(on)} | Turn-on Delay Time | Inductive Switching (25°C) | | 120 | | |
| T _r | Rise Time | $V_{GE} = \pm 15V$ | | 50 | | ns |
| T _{d(off)} | Turn-off Delay Time | $V_{Bus} = 600V$ $I_{C} = 100A$ | | 310 | | |
| T _f | Fall Time | $R_G = 5.6\Omega$ | | 20 | | |
| T _{d(on)} | Turn-on Delay Time | Inductive Switching (125°C) | | 130 | | |
| T _r | Rise Time | $V_{GE} = \pm 15V$ | | 60 | |] |
| T _{d(off)} | Turn-off Delay Time | $V_{Bus} = 600V$ $I_{C} = 100A$ | | 360 | | ns |
| $T_{\rm f}$ | Fall Time | $R_G = 5.6\Omega$ | | 30 | | |
| Eon | Turn-on Switching Energy | $V_{GE} = \pm 15V$ $V_{Bus} = 600V$ $T_j = 125^{\circ}C$ | | 12 | | T. |
| E _{off} | Turn-off Switching Energy | $\begin{array}{c} I_{C} = 100 A \\ R_{G} = 5.6 \Omega \end{array} \qquad T_{j} = 125^{\circ} C \end{array}$ | | 5 | | mJ |

Chopper diode ratings and characteristics

| Symbol | Characteristic | Test Conditions | | Min | Тур | Max | Unit |
|------------------|---|---------------------------|------------------------|------|------|-----|------|
| V _{RRM} | Maximum Peak Repetitive Reverse Voltage | | | 1200 | | | V |
| I _{RM} | Maximum Reverse Leakage Current | V _R =1200V | $T_j = 25^{\circ}C$ | | | 100 | μA |
| | | | $T_j = 125^{\circ}C$ | | 100 | 500 | |
| I _F | DC Forward Current | | $Tc = 90^{\circ}C$ | | 100 | | A |
| | Diode Forward Voltage | $I_{\rm F} = 100 {\rm A}$ | | | 2.4 | 3 | |
| V _F | | $I_{\rm F} = 150 {\rm A}$ | | | 2.7 | | V |
| | | $I_{\rm F} = 100 {\rm A}$ | $T_j = 125^{\circ}C$ | | 1.8 | | |
| t _{rr} | Reverse Recovery Time | $I_{\rm p} = 100 \Delta$ | $T_j = 25^{\circ}C$ | | 385 | | ns |
| чп | | | $T_{j} = 125^{\circ}C$ | | 480 | | |
| Q _{rr} | Reverse Recovery Charge | $di/dt = 200 A/\mu s$ | $T_j = 25^{\circ}C$ | | 1055 | | nC |
| Vrr | | | $T_{j} = 125^{\circ}C$ | | 5240 | | ne |

APTGF100DA120T1G-Rev 1 October, 2012



Thermal and package characteristics

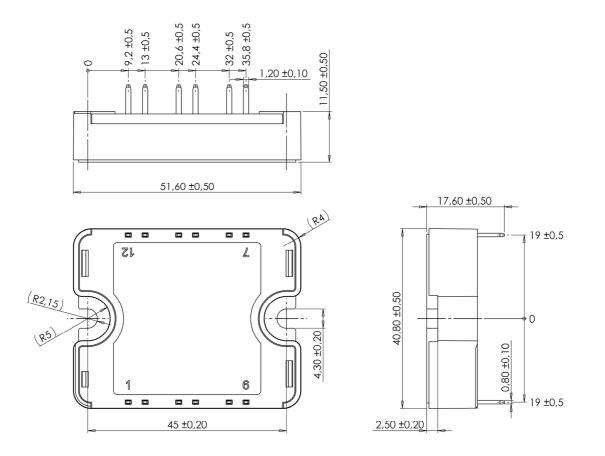
| Symbol | Characteristic | | | Min | Тур | Max | Unit |
|-------------------|---|------------|-------|------|-----|------|------|
| R _{thJC} | Junction to Case Thermal Resistance | | IGBT | | | 0.19 | °C/W |
| | | | Diode | | | 0.55 | C/ W |
| V _{ISOL} | RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz | | | 4000 | | | V |
| T _J | Operating junction temperature range | | | -40 | | 150 | |
| T _{STG} | Storage Temperature Range | | | -40 | | 125 | °C |
| T _C | Operating Case Temperature | | | | | 100 | |
| Torque | Mounting torque | To heatsin | k M4 | 2 | | 3 | N.m |
| Wt | Package Weight | | | | 80 | g | |

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

| Symbol | Characteristic | Min | Тур | Max | Unit |
|-----------------|-----------------------------|-----|------|-----|------|
| R ₂₅ | Resistance @ 25°C | | 50 | | kΩ |
| B 25/85 | $T_{25} = 298.15 \text{ K}$ | | 3952 | | Κ |

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature
R_T: Thermistor value at T

SP1 Package outline (dimensions in mm)



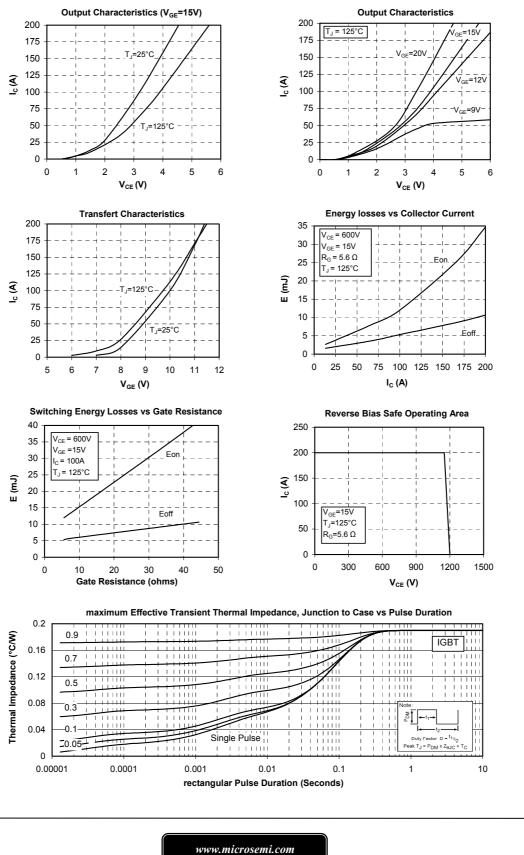
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

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3 - 6



Typical Performance Curve

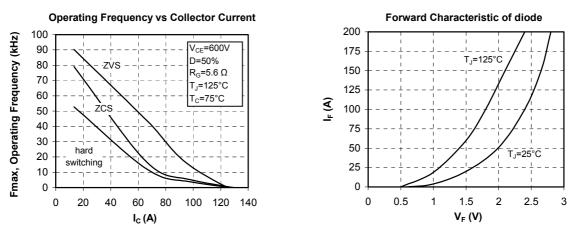


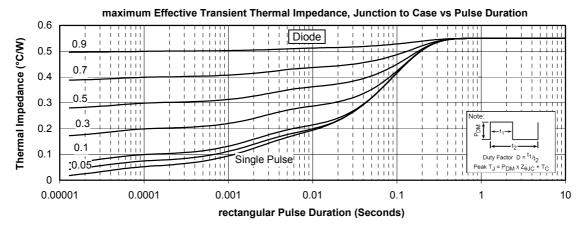
APTGF100DA120T1G

APTGF100DA120T1G - Rev 1 October, 2012

4 - 6







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